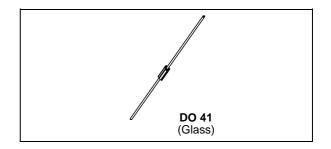


# SMALL SIGNAL SCHOTTKY DIODE

## **DESCRIPTION**

General purpose metal to silicon diode featuring very low turn-on voltage and fast switching.

This device has integrated protection against excessive voltage such as electrostatic discharges.



# **ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter	Value	Unit		
$V_{RRM}$	Repetitive Peak Reverse Voltage	80	V		
l <sub>F</sub>	Forward Continuous Current*	500	mA		
I <sub>FRM</sub>	Repetitive Peak Forward Current*	3	А		
I <sub>FSM</sub>	Surge non Repetitive Forward Current*	10	А		
T <sub>stg</sub> T <sub>j</sub>	Storage and Junction Temperature Range	- 65 to 150 - 65 to 125	°C °C		
T∟	Maximum Lead Temperature for Soldering during 10s at 4mm from Case 230				

#### THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
R <sub>th(j-a)</sub>	Junction-ambient*	110	°C/W

## **ELECTRICAL CHARACTERISTICS**

## STATIC CHARACTERISTICS

Symbol	Test Conditions	Min.	Тур.	Max.	Unit
I <sub>R</sub> * *	$T_j = 25^{\circ}C$ $V_R = 80V$			200	μΑ
V <sub>F</sub> * *	$T_j = 25$ °C $I_F = 10$ mA			0.32	V
	$T_j = 25^{\circ}C$ $I_F = 100mA$			0.42	
	$T_j = 25^{\circ}C$ $I_F = 1A$			1	

#### DYNAMIC CHARACTERISTICS

Symbol	Test Conditions				Тур.	Max.	Unit
С	T <sub>j</sub> = 25°C	f = 1MHz	$V_R = 0V$		120		pF
			$V_R = 5V$		35		

<sup>\*</sup> On infinite heatsink with 4mm lead length \*\* Pulse test:  $t_p \le 300 \mu s$   $\delta < 2\%$ .

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Figure 1. Forward current versus forward voltage at low level (typical values).

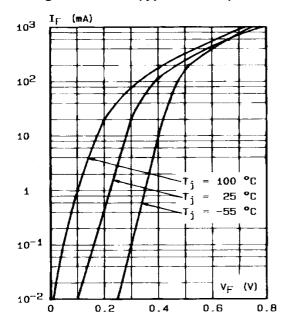


Figure 2. Forward current versus forward voltage at high level (typical values).

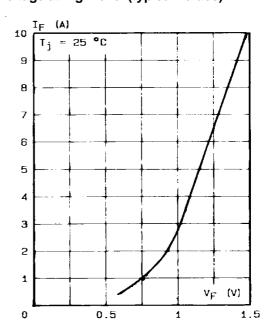


Figure 3. Reverse current versus junction temperature.

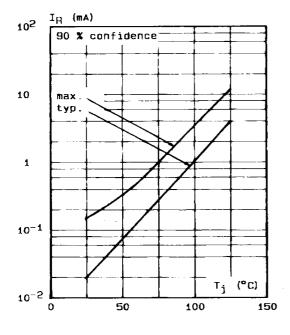


Figure 4. Reverse current versus  $\ensuremath{V_{\text{RRM}}}$  in per cent.

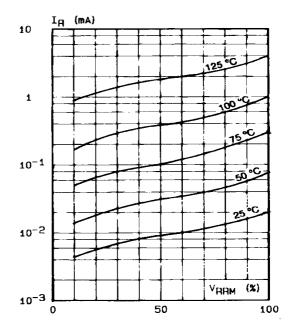


Figure 5. Capacitance C versus reverse applied voltage  $V_{\mbox{\scriptsize R}}$  (typical values).

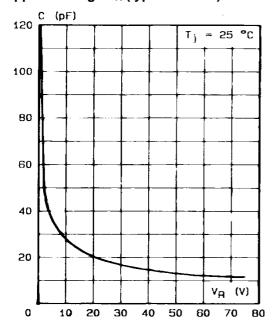


Figure 6. Surge non repetitive forward current for a rectangular pulse with  $t \le 10$  ms.

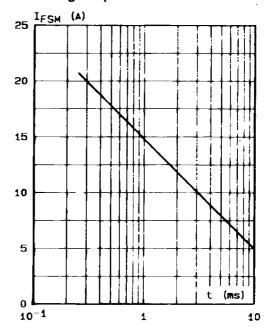
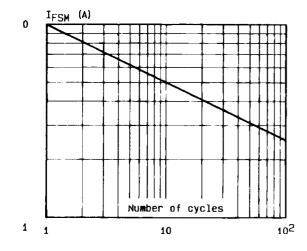
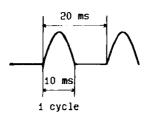


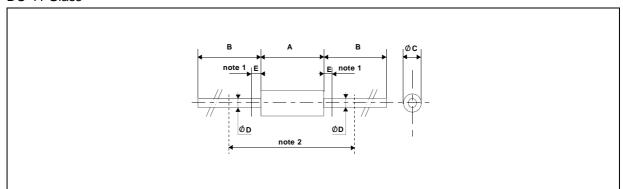
Figure 7. Surge non repetitive forward current versus number of cycles.





# PACKAGE MECHANICAL DATA

#### DO 41 Glass



		DIMENSIONS				
REF. Millimeters		Inches		NOTES		
	Min.	Max.	Min.	Max.		
Α	4.070	5.200	0.160	0.205	1 - The lead diameter Ø D is not controlled over zone E	
В	28		1.102		The lead diameter & B is not someoned ever 25me E	
ØC	2.040	2.710	0.080	0.107	2 - The minimum axial lengh within which the device may be	
ØD	0.712	0.863	0.028	0.034	placed with its leads bent at right angles is 0.59"(15 mm)	
Е		1.27		0.050		

Cooling method : by convection and conduction Marking: clear, ring at cathode end. Weight: 0.34g

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